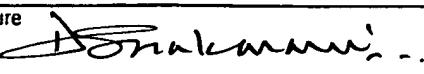


Substitute Form PTO-1449 Modified: JUL 12 2004 16 CFR 1.98(e) U.S. Patent and Trademark Office		U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 08917-097001	Application No. 10/822,114
Information Disclosure Statement by Applicant (Use several sheets if necessary)		Applicant Nobuhisa Noda et al.		
		Filing Date April 9, 2004	Group Art Unit 1773	

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							Yes No
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Examiner Signature 	Date Considered 3/09/2006
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